KEMET Part Number: T540D337M006BH8510



Tantalum, Polymer Tantalum, COTS, T540_COTS, 330 uF, 20%, 6.3 V, 7343, SMD, Polymer, Molded, COTS, B (0.1%/1000 Hrs), 40 mOhms, Height Max = 3.1mm



Dimensions		
Footprint	7343	
L	7.3mm +/-0.3mm	
W	4.3mm +/-0.3mm	
Н	2.8mm +/-0.3mm	
Т	0.13mm REF	
S	1.3mm +/-0.3mm	
F	2.4mm +/-0.1mm	
Α	3.8mm MIN	
В	0.5mm +/-0.15mm	
E	3.5mm REF	
G	3.5mm REF	
Р	0.9mm REF	
R	1mm REF	
Х	0.1mm +/-0.1mm	

Packaging Specifications		
Weight:	352.36 mg	
Packaging:	T&R, 178mm	
Packaging Quantity:	500	

General Information		
Dielectric:	Polymer Tantalum	
Style:	SMD Chip	
Series:	T540_COTS	
Description:	SMD, Polymer, Molded, COTS	
Features:	Non-Combustible, Low ESR, COTS	
RoHS:	No	
Termination:	Solder Coated	
Approvals:	DLA Drawing 04051	
Notes:	In Polarity Stripe, At KEMET's Option, Type May Be Indicated: No Symbol = Standard (Or Low Leakage) MnO2 Tantalum Chip, O = LowESR T494, R = Low ESR T495, F = Fused T496, HT = 150C Rated T498 (or B45196P, B45198P), H = 175C rated T499, M = Multiple Anode	

Specifications	
Capacitance:	330 uF
Capacitance Tolerance:	20%
Voltage DC:	6.3 VDC (85C), 4.22 VDC (125C)
Temperature Range:	-55/+125C
Dissipation Factor:	10% 120Hz 25C
Failure Rate:	B (0.1%/1000 Hrs)
Resistance:	40 mOhms (100kHz 25C)
Current:	2372 mAmps (100kHz 45C)
Leakage Current:	208 uA (5min 25C)
Testing and Reliability:	4 Cycles At 25C +/-5C & Improved Humidity Capability



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